

N-Channel Logic Level Enhancement Mode Field Effect Transistor

NDT014L

General Description

These N-Channel logic level enhancement mode power field effect transistors are produced using **onsemi's** proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as DC motor control and DC-DC conversion where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- 2.8 A, 60 V. $R_{DS(ON)} = 0.2 \Omega$ @ $V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 0.16 \Omega$ @ $V_{GS} = 10 \text{ V}$
- High Density Cell Design For Extremely Low R_{DS(ON)}
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- This Device is Pb-Free

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, unless otherwise noted)

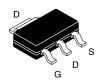
Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	60	V
V _{GSS}	Gate-Source Voltage	±20	V
I _D	Drain Current - Continuous (Note 1a)	±2.8	Α
	- Pulsed	±10	
P_{D}	Maximum Power Dissipation (Note 1a)	3	W
	(Note 1b)	1.3	
	(Note 1c)	1.1	
T _J , T _{STG}	Operating and Storage Temperature Range	-65 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

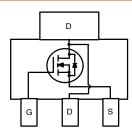
THERMAL CHARACTERISTICS Values are at $T_A = 25$ °C unless otherwise noted.

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	42	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	12	°C/W

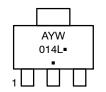
1



SOT-223 CASE 318H



MARKING DIAGRAM



A = Assembly Location

Y = Year W = Work Week

014L = Specific Device Code ■ = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NDT014L	SOT-223	4000 /
		Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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ELECTRICAL CHARACTERISTICS Values are at $T_A = 25$ °C unless otherwise noted.

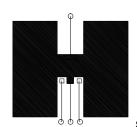
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
OFF CH	ARACTERISTICS	•		•	•	•
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	60	_	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$ $T_{J} = 55^{\circ}\text{C}$	-	-	25 250	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V	_	-	100	nΑ
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	_	-	-100	nΑ
ON CHA	RACTERISTICS (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ $T_J = 125^{\circ}\text{C}$	1 0.8	1.5 1.1	3 2	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 2.8 \text{ A}$ $T_J = 125^{\circ}\text{C}$	-	0.17 0.22	0.2 0.36	Ω
		$V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$	_	0.12	0.16	1
I _{D(on)}	On-State Drain Current	V _{GS} = 4.5 V, V _{DS} = 5 V	5	-	-	Α
		V _{DS} = 10 V, V _{DS} = 5 V	10	-	-	
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 2.8 A	_	4.2	-	S
DYNAMI	C CHARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 30 V, V _{GS} = 0 V, f = 1.0 MHz	_	214	_	pF
C _{oss}	Output Capacitance	f = 1.0 MHz	_	70	-	pF
C_{rss}	Reverse Transfer Capacitance		_	27	-	pF
SWITCH	ING CHARACTERISTICS (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 30 \text{ V}, I_{D} = 3 \text{ A},$	_	6	12	ns
t _r	Turn-On Rise Time	$V_{GEN} = 10 \text{ V, } R_{GEN} = 12 \Omega$	_	14	25	ns
t _{d(off)}	Turn-Off Delay Time	7	_	15	28	ns
t _f	Turn-Off Fall Time	7	_	10	18	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, I_D = 2.8 \text{ A},$	_	36	5	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 4.5 V	_	0.8	-	nC
Q_{gd}	Gate-Drain Charge		_	1.4	-	nC
DRAIN-S	SOURCE DIODE CHARACTERISTICS A	AND MAXIMUM RATINGS				
I _S	Maximum Continuous Drain-Source Diode Forward Current		_	-	2.3	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.3 A (Note 2)	-	0.85	1.3	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_F = 2.3 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$	_	_	140	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

$$P_D(t) \,=\, \frac{T_J - T_A}{R_{\theta JA}(t)} = \frac{T_J - T_A}{R_{\theta JC} \,+\, R_{\theta CA}(t)} =\, I_D^2(t) \,\times\, R_{DS(on)@T_J}$$

Applications on 4.5"x5" FR-4 PCB under still air environment, typical $R_{\theta JA}$ is found to be:



a. 42°C/W with 1 in² of 2 oz copper mounting



b. 95°C/W with 0.066 in² of 2 oz copper mounting pad.



c. 110°C/W with 0.0123 in² of 2 oz copper mounting pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤2.0%.

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TYPICAL CHARACTERISTICS

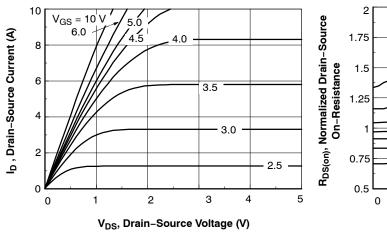


Figure 1. On-Region Characteristics

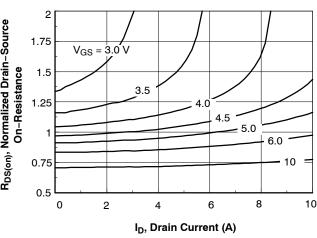


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current

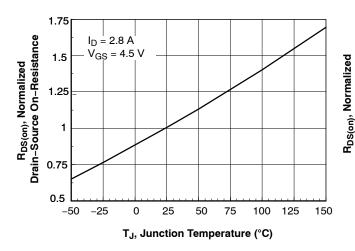


Figure 3. On–Resistance Variation with Temperature

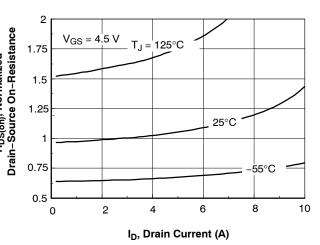


Figure 4. On–Resistance Variation with Drain Current and Temperature

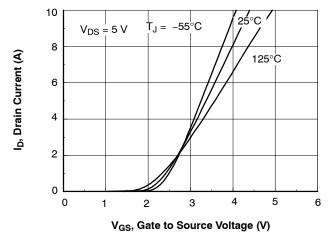


Figure 5. Transfer Characteristics

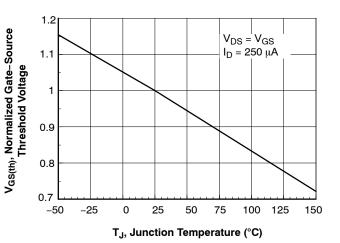


Figure 6. Gate Threshold Variation with Temperature

TYPICAL CHARACTERISTICS (continued)

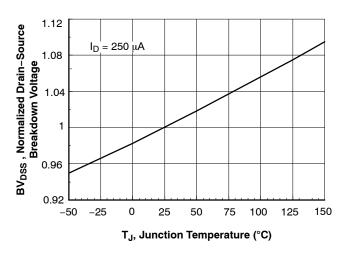
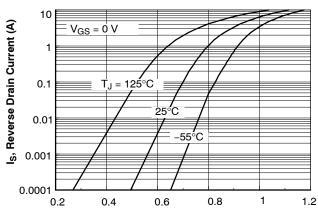


Figure 7. Breakdown Voltage Variation with Temperature



V_{SD}, Body Diode Forward Voltage (V)

Figure 8. Body Diode Forward Voltage Variation with Current and Temperature

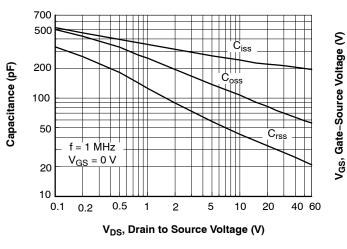


Figure 9. Capacitance Characteristics

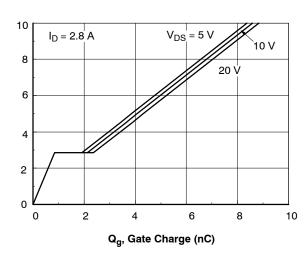


Figure 10. Gate Charge Characteristics

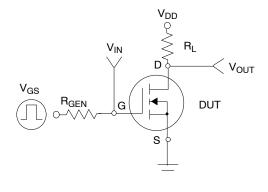


Figure 11. Switching Test Circuit

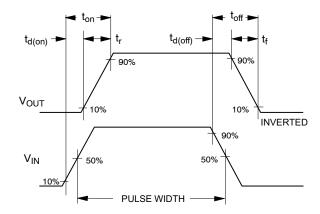


Figure 12. Switching Waveforms

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TYPICAL CHARACTERISTICS (continued)

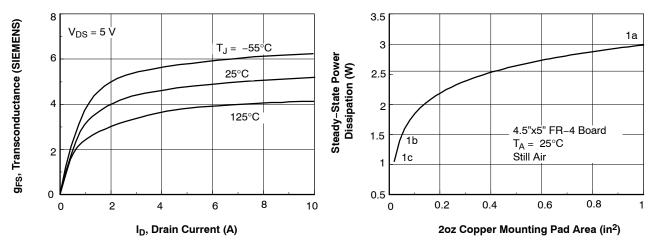
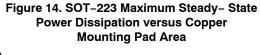


Figure 13. Transconductance Variation with Drain Current and Temperature



10 μs

30 50 80

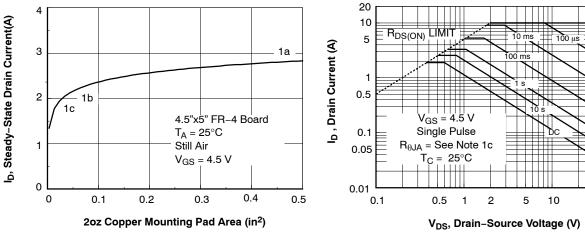


Figure 15. Maximum Steady- State Drain Current versus Copper Mounting Pad Area

Figure 16. Maximum Safe Operating Area

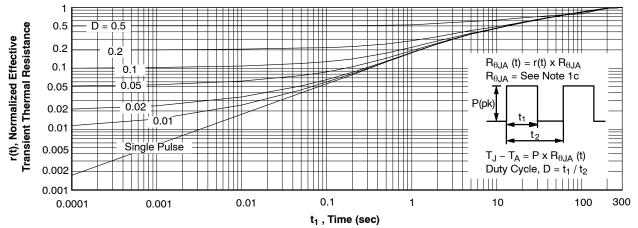


Figure 17. Typical Transient Thermal Impedance Curve

Thermal characterization performed under the conditions of Note 1c. Should better thermal design employs, $R_{\theta JA}$ will be lower and reach thermal equivalent sooner.

SCALE 2:1



A

В

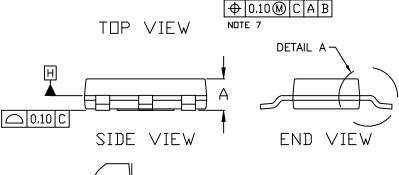
DATE 13 MAY 2020

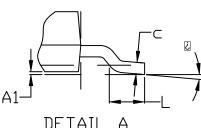
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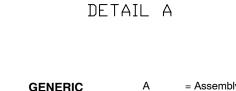
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- DIMENSIDNING AND TOLERANCING PER ASME
 Y14.5M, 2009.
 CONTROLLING DIMENSION: MILLIMETERS
 DIMENSIONS D & E1 ARE DETERMINED AT DATUM
 H. DIMENSIONS DO NOT INCLUDE MOLD FLASH,
 PROTRUSIONS DR GATE BURRS. SHALL NOT
 EXCEED 0.23mm PER SIDE.
 LEAD DIMENSIONS & AND &1 DO NOT INCLUDE
 DAMBAR PROTRUSION. ALLOWABLE DAMBBAR
 PROTRUSION IS 0.08mm PER SIDE.
 DATUMS A AND B ARE DETERMINED AT DATUM H.
 A1 IS DEFINED AS THE VERTICAL DISTANCE
 FROM THE SEATING PLANE TO THE LOWEST
 POINT OF THE PACKAGE BODY.
 POSITIONAL TOLERANCE APPLIES TO DIMENSIONS
 & AND &1.

- b AND b1.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α			1.80	
A1	0.02	0.06	0.11	
b	0.60	0.74	0.88	
b1	2.90	3.00	3.10	
c	0.24		0.35	
D	6.30	6.50	6.70	
E	6.70	7.00	7.30	
E1	3.30	3.50	3.70	
е	2.30 BSC			
L	0.25			
į.	0°		10°	







MARKING DIAGRAM*

AYW

XXXXX.

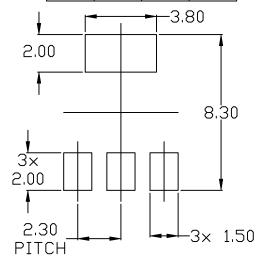
= Assembly Location = Year

= Work Week W

XXXXX = Specific Device Code = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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